

•General Description

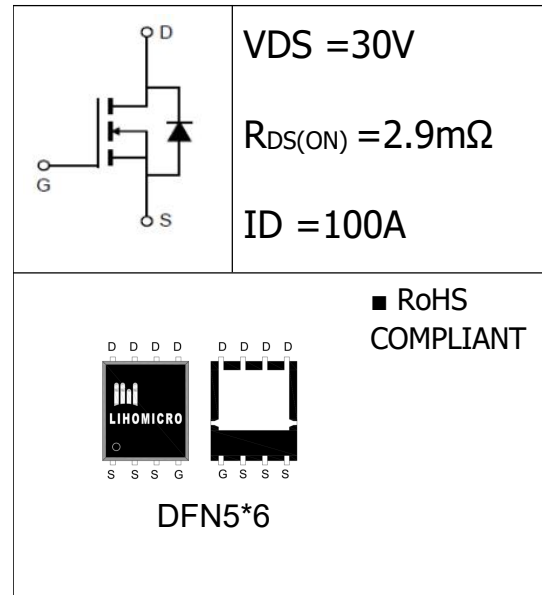
The MOSFET LH100N03 has the low $R_{DS(on)}$, low gate charge, fast switching and excellent avalanche characteristics. This device is suitable for fast charge and lighting.

•Features

- Fast switching
- Low $R_{DS(on)}$ & FOM
- Low Miller Capacitance

•Application

- LED/LCD/PDP TV and monitor Lighting
- Power Supplies
- PD Charger



•Ordering Information:

Part Number	LH100N03
Package	DFN5*6
Basic Ordering Unit (pcs)	5000
Normal Package Material Ordering Code	LH100N03N-DFN5*6-TAP
Halogen Free Ordering Code	LH100N03N-DFN5*6-TAP-HF

•Absolute Maximum Ratings (TC = 25°C)

PARAMETER	SYMBOL	Value	UNIT
Drain-Source Breakdown Voltage	BV_{DSS}	30	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current, $T_C = 25^\circ C$	I_D	100	A
Pulsed drain current (TC = 25°C, tp limited by Tjmax) ¹	I_D pulse	300	A
Single Pulse Avalanche Energy ²	E_{AS}	560	mJ
Power Dissipation (TC=25°C)	P_D	80	W
Operating Temperature	T_J	-55~+150	°C
Storage Temperature	T_{STG}	-55~+150	°C

●Electronic Characteristics

PARAMETER	SYMBOL	TEST CONDITION	MIN	TYP	MAX	UNIT
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	30	--	--	V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	1.0	--	3.0	V
Drain-source On Resistance ³	$R_{DS(ON)}$	$V_{GS}=10V, I_D=40A$	--	2.9	3.4	mΩ
		$V_{GS}=4.5V, I_D=30A$	--	4.8	6.3	
Drain-Source Leakage Current	I_{DSS}	$V_{DS}=30V, V_{GS}=0V, T_J=25^\circ C$	--	--	1	μA
		$V_{DS}=30V, V_{GS}=0V, T_J=85^\circ C$	--	--	10	
Gate-Source Leakage Current	I_{GSS}	$V_{GS}=\pm 20, V_{DS}=0V$	--	--	±100	nA
Input Capacitance	C_{iss}	$V_{GS}=0V,$ $V_{DS}=25V$ $f=1.0MHz$	--	2890	--	pF
Output Capacitance	C_{oss}		--	312	--	
Reverse transfer Capacitance	C_{rss}		--	277	--	
Turn-on Delay Time	$T_{d(on)}$	$V_{DD}=15V$ $V_{GS}=10V,$ $I_D=30.0A$ $R_G=2.4\Omega$	--	30	--	ns
Turn-on Rise Time	T_R		--	--	--	
Turn -Off Delay Time	$T_{d(off)}$		--	58	--	
Fall Time	T_f		--	19.5	--	
Total Gate Charge	Q_g	$I_D=30A,$ $V_{DS}=24V$ $V_{GS}=4.5V$	--	32.4	---	nC
Gate-to-Source Charge	Q_{gs}		--	12.5	--	
Gate-to-Drain Charge	Q_{gd}		--	17	---	
Continuous Diode Forward Current	I_S	--	--	--	100	A
Diode Forward Voltage	V_{SD}	$T_J=25^\circ C, I_S=10.0A$ $V_{GS}=0V$	--	--	1.2	V

●Thermal Characteristics

PARAMETER	SYMBOL	MAX	UNIT
Thermal Resistance Junction-case	R_{thJC}	2.5	°C/W
Thermal Resistance Junction-ambient	R_{thJA}	40	°C/W

Notes:

1.Repetitive Rating: Pulse width limited by maximum junction temperature.

2. $I_{AS}=40A, L=0.5Mh, V_{DD}=15V, R_G=25\Omega$, Starting $T_J=25^\circ C$

3.Pulse Test : Pulse width ≤ 300μs, Duty cycle ≤ 2%

•Typical Characteristics

Fig.1 Power Dissipation

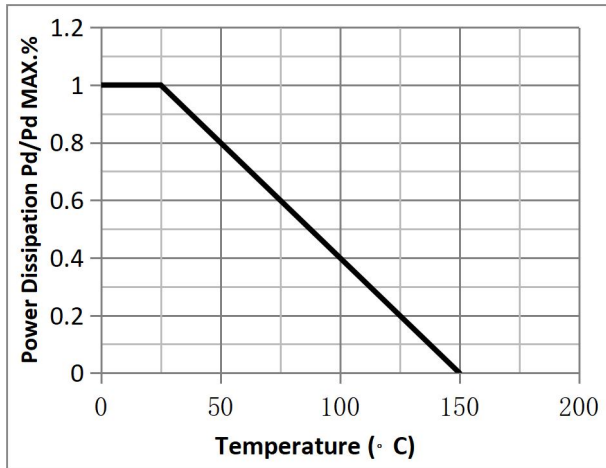


Fig.2 Typical output Characteristics

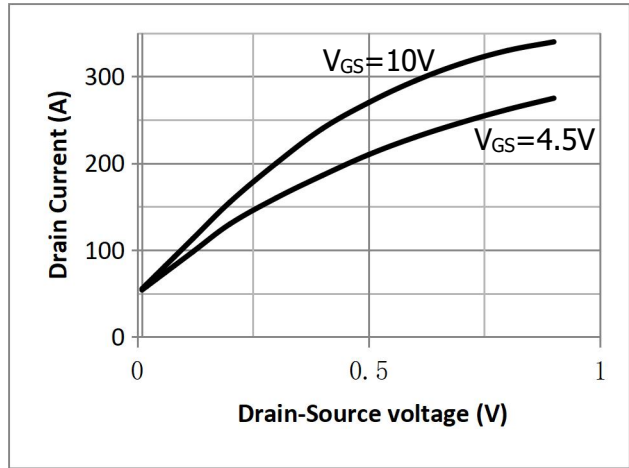


Fig.3 Threshold Voltage V.S Junction Temperature

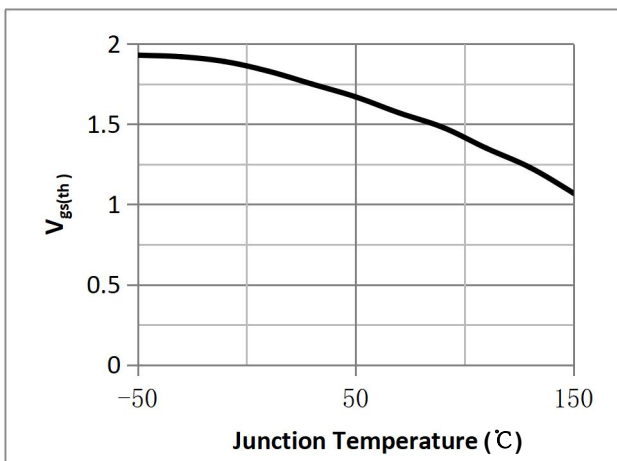


Fig.4 Resistance V.S Drain Current

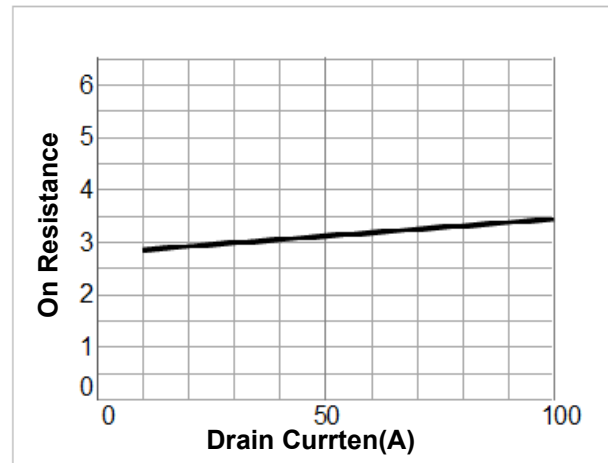


Fig.5 On-Resistance VS Gate Source Voltage

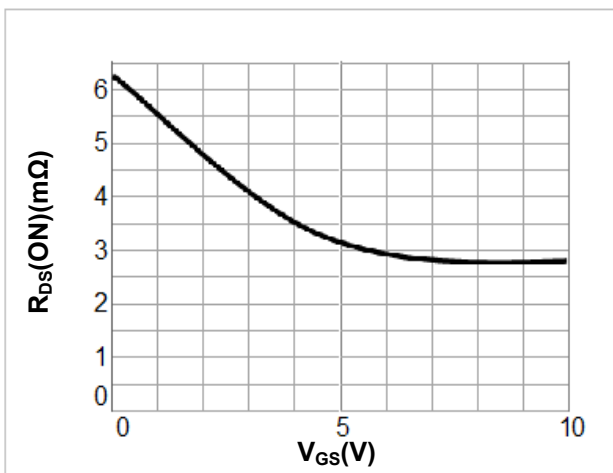
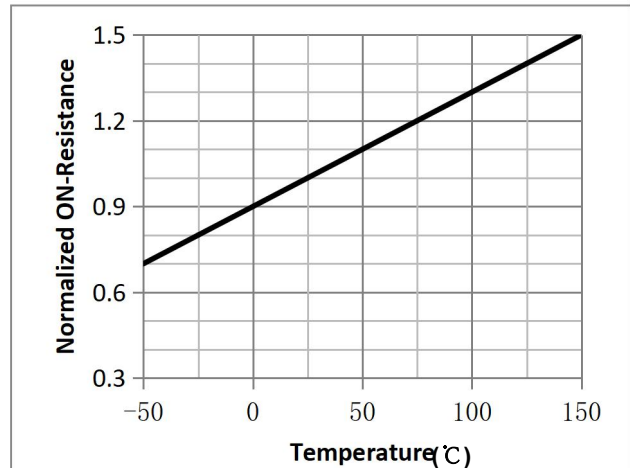


Fig.6 On-Resistance V.S Junction Temperature



• **Test Circuits & Waveforms**

Fig.7 Switching Time Measurement Circuit

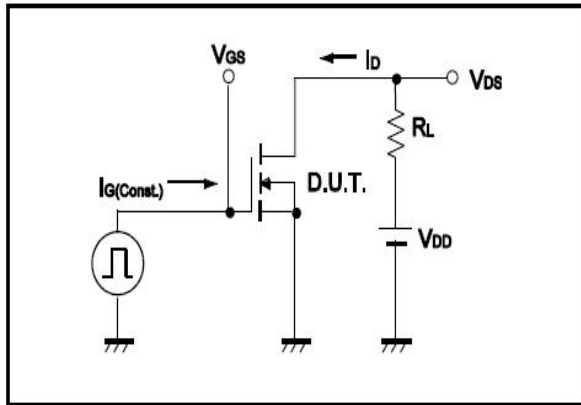


Fig.8 Gate Charge Waveform

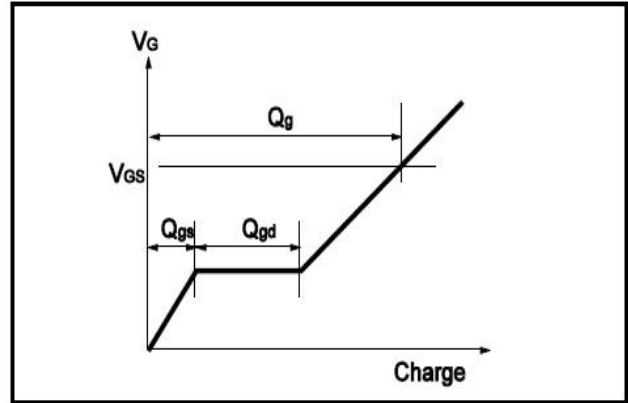


Fig.9 Switching Time Measurement Circuit

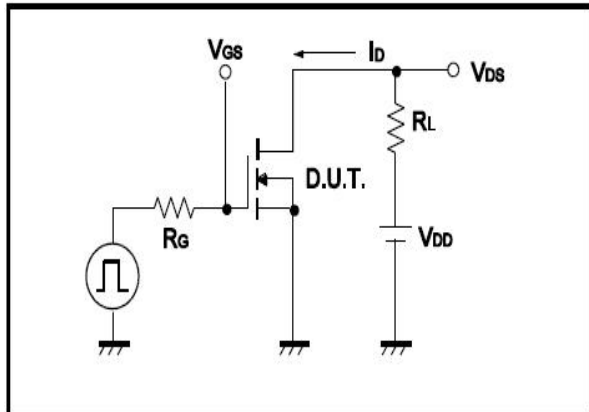


Fig.10 Gate Charge Waveform

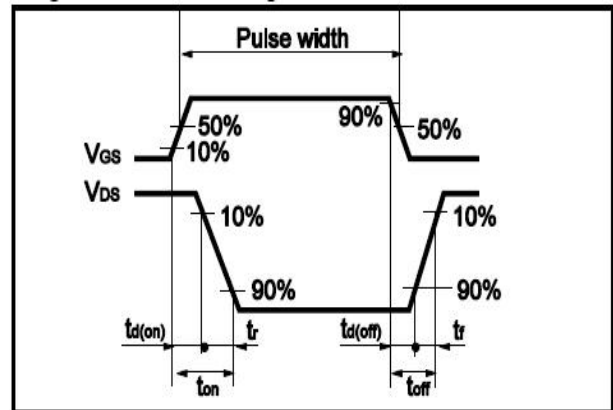


Fig.11 Avalanche Measurement Circuit

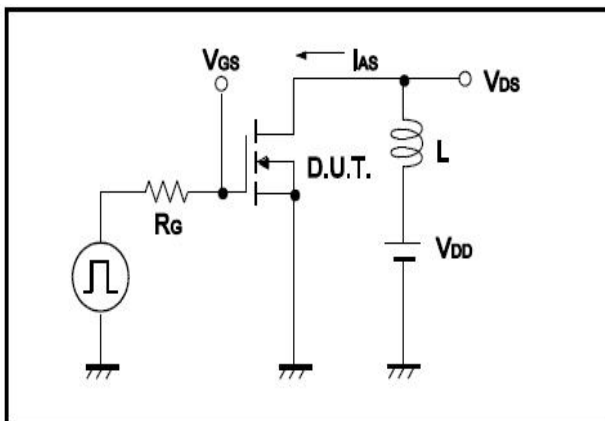
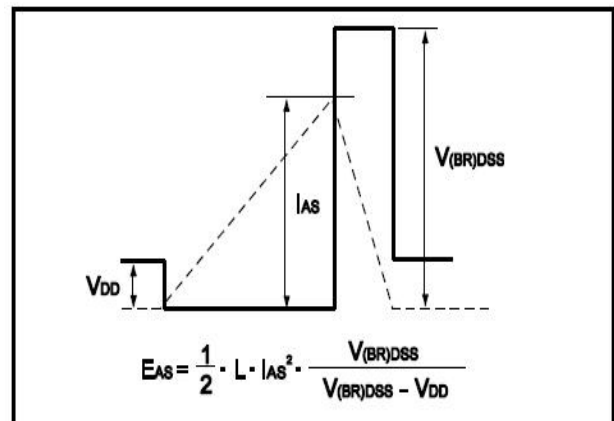


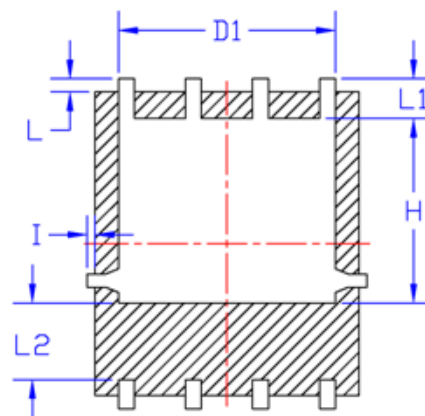
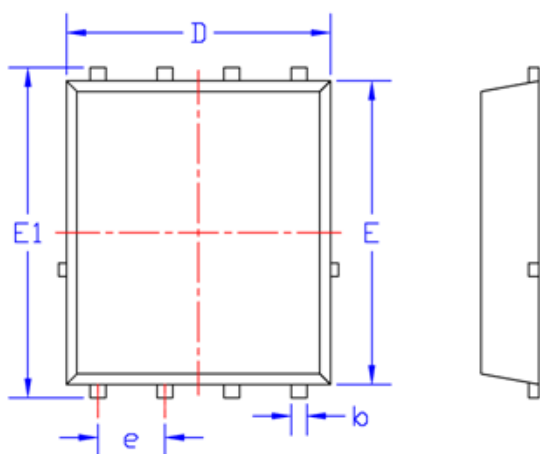
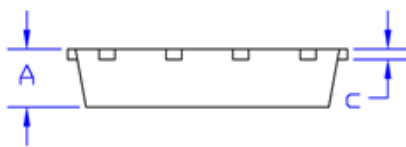
Fig.12 Avalanche Waveform



• **Dimensions (DFN5*6)**

Unit: mm

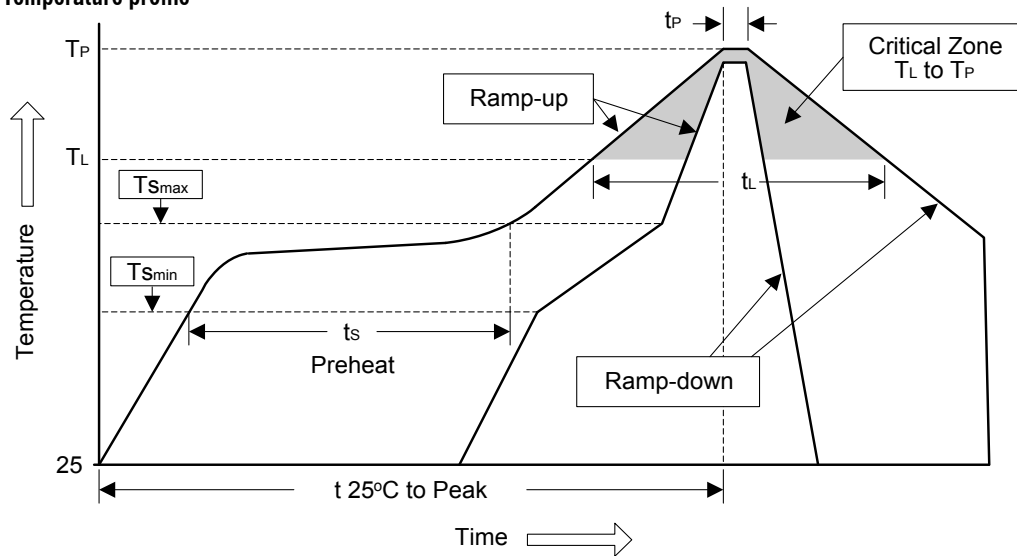
SYMBOL	min	max	SYMBOL	min	max
A	1.00	1.20	e	1.27BSC	
b	0.30	0.50	L	0.05	0.30
c	0.20	0.30	L1	0.40	0.80
D	4.80	5.20	L2	1.20	2.00
D1	3.90	4.30	H	3.30	3.80
E	5.50	5.90	I	—	0.18
E1	5.90	6.40			



• Soldering Methods for Silicongear's Products

1. Storage environment: Temperature=10°C to 35°C Humidity=65%±15%
2. Reflow soldering of surface-mount devices

Figure 1: Temperature profile



Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Average ramp-up rate (T_L to T_P)	<3°C/sec	<3°C/sec
Preheat		
- Temperature Min (T_{smin})	100°C	150°C
- Temperature Max (T_{smax})	150°C	200°C
- Time (min to max) (t_s)	60 to 120 sec	60 to 180 sec
T_{smax} to T_L		
- Ramp-up Rate	<3°C/sec	<3°C/sec
Time maintained above:		
- Temperature (T_L)	183°C	217°C
- Time (t_L)	60 to 150 sec	60 to 150 sec
Peak Temperature (T_P)	240°C +0/-5°C	260°C +0/-5°C
Time within 5°C of actual Peak Temperature (t_P)	10 to 30 sec	20 to 40 sec
Ramp-down Rate	<6°C/sec	<6°C/sec
Time 25°C to Peak Temperature	<6 minutes	<8 minutes

3. Flow (wave) soldering (solder dipping)

Products	Peak Temperature	Dipping Time
Pb devices.	245°C ±5°C	5sec ±1sec
Pb-Free devices.	260°C +0/-5°C	5sec ±1sec